

# $\mu$ A431A Adjustable Precision Zener Shunt Regulator

Linear Division Voltage Regulators

## Description

The  $\mu$ A431A is a 3-terminal adjustable shunt regulator with guaranteed temperature stability over the entire temperature range of operation. The output voltage may be set at any level greater than 2.5 V ( $V_{REF}$ ) up to 36 V merely by selecting two external resistors that act as a voltage divided network. Due to the sharp turn-on characteristics this device is an excellent replacement for many zener diode applications.

- Average Temperature Coefficient 50 ppm/°C
- Temperature Compensated For Operation Over The Full Temperature Range
- Programmable Output Voltage
- Fast Turn-On Response
- Low Output Noise

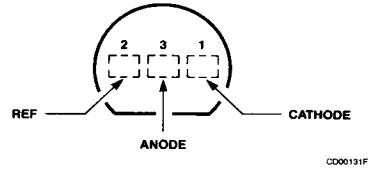
## Absolute Maximum Ratings

Storage Temperature Range	-65°C to +150°C	
Operating Temperature Range		
Industrial ( $\mu$ A431AV)	-40°C to +85°C	
Commercial ( $\mu$ A431AC)	0°C to +70°C	
Lead Temperature		
TO-92 Package/SO-8		
(soldering, 10 s)	265°C	
Internal Power Dissipation <sup>1,2</sup>		
TO-92 Package	0.78 W	
SO-8 Package	0.81 W	
Cathode Voltage	37 V	
Continuous Cathode Current	-10 mA to +150 mA	
Reference Voltage	-0.5 V	
Reference Input Current	10 mA	
Operating Conditions	Min	Max
Cathode Voltage	$V_{REF}$	37 V
Cathode Current	1.0 mA	100 mA

## Notes

1.  $T_J$  Max = 150°C.
2. Ratings apply to ambient temperature at 25°C. Above this temperature, derate the TO-92 at 6.2 mW/°C, and the SO-8 at 6.5 mW/°C.

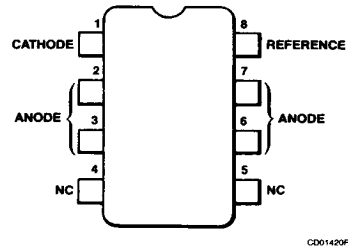
## Connection Diagram TO-92 Package (Top View)



## Order Information

Device Code	Package Code	Package Description
$\mu$ A431AWC	EI	Molded
$\mu$ A431AWV	EI	Molded

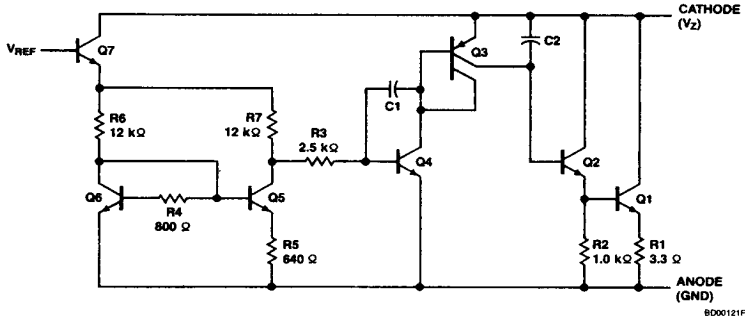
## Connection Diagram SO-8 Package (Top View)



## Order Information

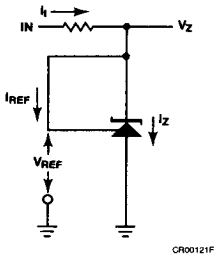
Device Code	Package Code	Package Description
$\mu$ A431ASC	KC	Molded Surface Mount

**Equivalent Circuit**



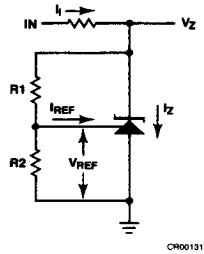
**DC Test Circuits**

**Figure 1 Test Circuit For  $V_z = V_{REF}$**



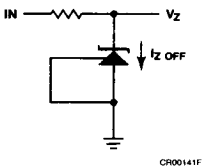
CR00121F

**Figure 2 Test Circuit For  $V_z > V_{REF}$**



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**Figure 3 Test Circuit For Off-State Current**



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**Note**

$$V_z = V_{REF} (1 + R_1/R_2) + I_{REF} \cdot R_1$$

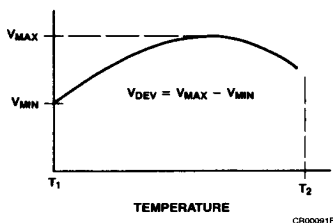
## μA431A

**Electrical Characteristics**  $T_A = 25^\circ\text{C}$  unless otherwise specified.

Symbol	Characteristic	Condition	Min	Typ	Max	Unit	
$V_{REF}$	Reference Voltage	$V_Z = V_{REF}$ , $I_I = 10\text{ mA}$ , Fig. 1	2.440	2.495	2.550	V	
$V_{DEV}$	Deviation of Reference Input Voltage Over Temperature <sup>1</sup>	$V_Z = V_{REF}$ , $I_I = 10\text{ mA}$ , $T_A = \text{full range}$ , Fig. 1		8.0	17	mV	
$\frac{\Delta V_{REF}}{\Delta V_Z}$	Ratio of the Change in Reference Voltage to the Change in Cathode Voltage	$I_Z = 10\text{ mA}$ , Fig. 2	$V_Z$ from $V_{REF}$ to 10 V		-1.4	-2.7	mV/V
			$V_Z$ from 10 V to 36 V		-1.0	-2.0	
$I_{REF}$	Reference Input Current	$R_1 = 10\text{ k}\Omega$ , $R_2 = \infty$ , $I_I = 10\text{ mA}$ , Fig. 2		2.0	4.0	$\mu\text{A}$	
$\alpha I_{REF}$	Deviation of Reference Input Current over Temperature	$R_1 = 10\text{ k}\Omega$ , $R_2 = \infty$ , $I_I = 10\text{ mA}$ , $T_A = \text{Full Range}$ , Fig. 2		0.4	1.2	$\mu\text{A}$	
$I_{Z(MIN)}$	Minimum Cathode Current for Regulation	$V_Z = V_{REF}$ , Fig. 1		0.4	1.0	mA	
$I_{Z(OFF)}$	Off-State Current	$V_Z = 36\text{ V}$ , $V_{REF} = 0\text{ V}$ , Fig. 3		0.3	1.0	$\mu\text{A}$	
$r_Z$	Dynamic Output Impedance <sup>2</sup>	$V_Z = V_{REF}$ , Frequency = 0 Hz, Fig. 1			.75	$\Omega$	

### Notes

1. Deviation of reference input voltage,  $V_{DEV}$ , is defined as the maximum variation of the reference input voltage over the full temperature range.



The average temperature coefficient of the reference input voltage,  $\alpha V_{REF}$ , is defined as:

$$\alpha V_{REF} \frac{\text{ppm}}{^\circ\text{C}} = \pm \left[ \frac{V_{MAX} - V_{MIN}}{V_{REF}(\text{at } 25^\circ\text{C})} \right] 10^6 = \pm \left[ \frac{V_{DEV}}{V_{REF}(\text{at } 25^\circ\text{C})} \right] 10^6$$

Where:

$T_2 - T_1 = \text{full temperature change.}$

$\alpha V_{REF}$  can be positive or negative depending on whether the slope is positive or negative.

Example:  $V_{DEV} = 8.0\text{ mV}$ ,  $V_{REF} = 2495\text{ mV}$ ,  $T_2 - T_1 = 70^\circ\text{C}$ , slope is positive

$$\alpha V_{REF} = \left[ \frac{8.0\text{ mV}}{2495\text{ mV}} \right] 10^6 = +46\text{ ppm}/^\circ\text{C}$$

2. The dynamic output impedance,  $r_Z$ , is defined as:

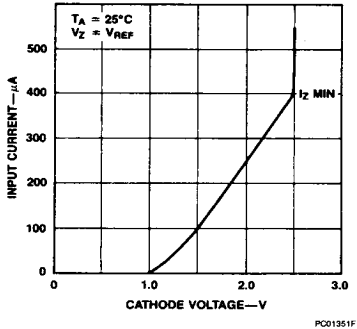
$$r_Z = \frac{\Delta V_Z}{\Delta I_Z}$$

When the device is programmed with two external resistors,  $R_1$  and  $R_2$ , (see Figure 2), the dynamic output impedance of the overall circuit,  $r_Z$ , is defined as:

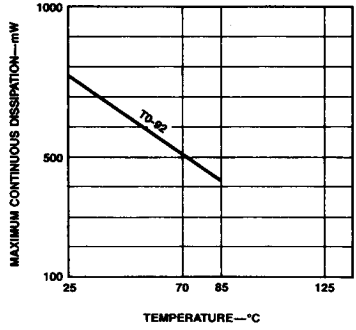
$$r_Z = \frac{\Delta V_Z}{\Delta I_Z} \cong \left[ r_Z 1 + \frac{R_1}{R_2} \right]$$

Typical Performance Curves

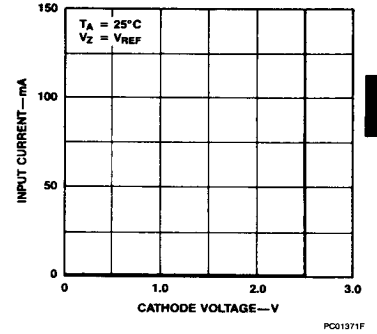
Input Current vs  $V_Z$



Thermal Information

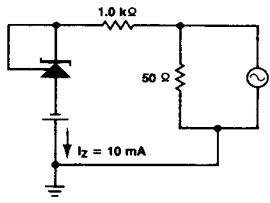
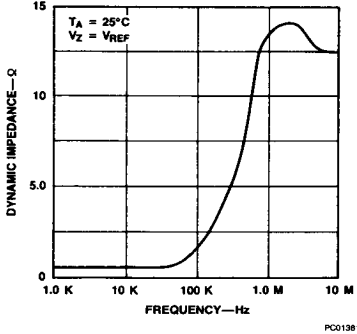


Input Current vs  $V_Z$

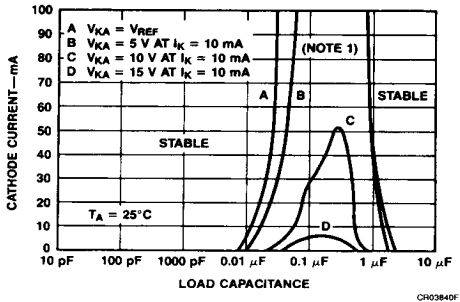


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Dynamic Impedance vs Frequency



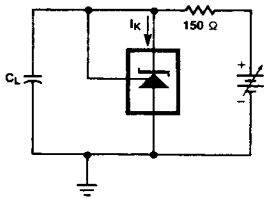
Stability Boundary Conditions



**Note**  
1. The areas under the curves represent conditions that may cause the device to oscillate. For curves B, C, and D, R2 and V+ were adjusted to establish the initial  $V_{KA}$  and  $I_K$  conditions with  $C_L = 0$ .  $V_+$  and  $C_L$  were then adjusted to determine the ranges of stability.

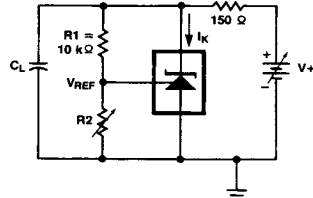
Typical Characteristics

Test Circuit For Curve A Below



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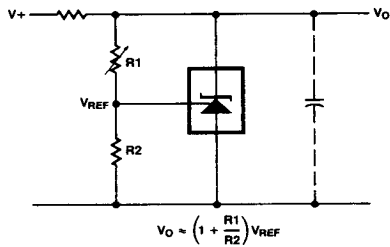
Test Circuit for Curves B, C, And D Below



CR09830F

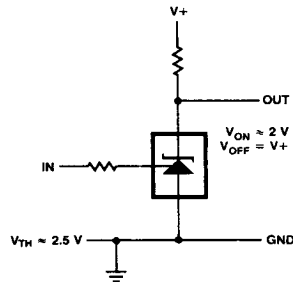
Typical Applications

Shunt Regulator



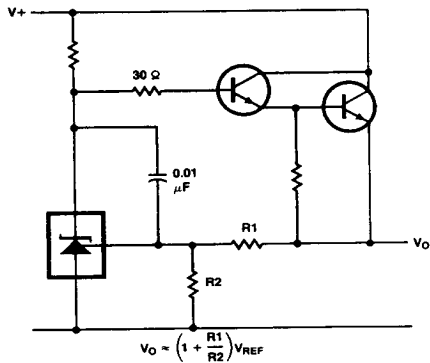
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Single Supply Comparator With Temperature Compensated Threshold



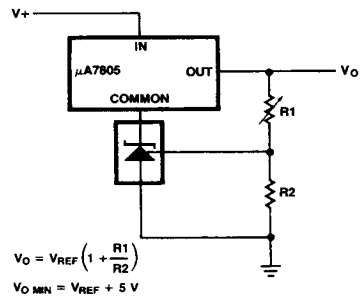
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Series Regulator



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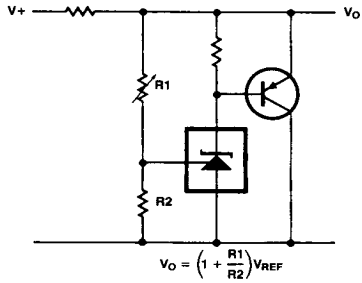
Output Control of a Three Terminal Fixed Regulator



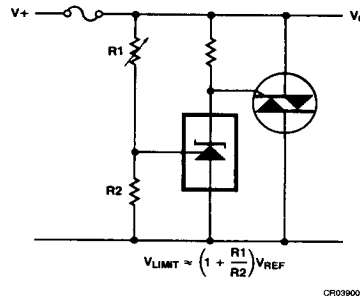
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Typical Applications (Cont.)

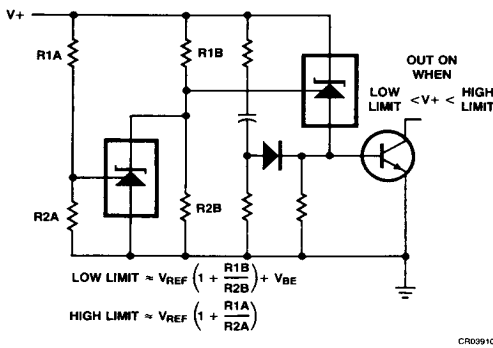
Higher Current Shunt Regulator



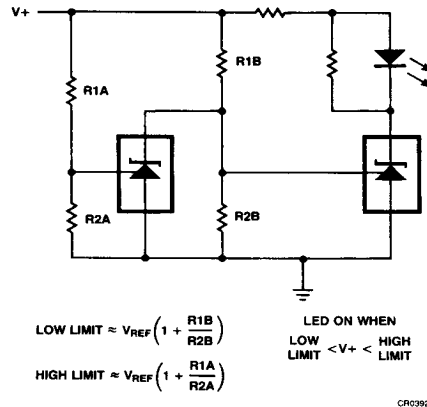
Crow Bar



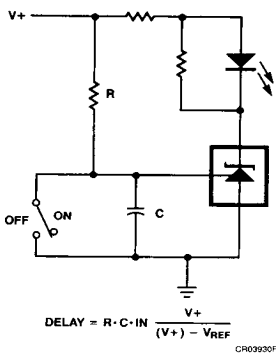
Over Voltage/Under Voltage Protection Circuit



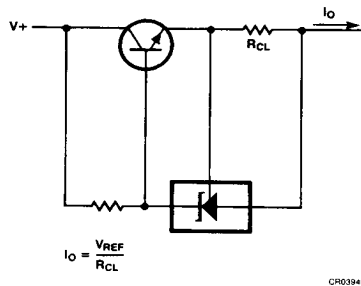
Voltage Monitor



Delay Timer



Current Limiter Or Current Source



Constant Current Sink

